

WST33H0NC

2.4-2.5 GHz, 300 W GaN Transistor

Description

Wolfspeed's WST33H0NC is a 300W packaged, partially-matched transistor utilizing Wolfspeed's high performance, 50V, 0.25um GaN on SiC production process. The WST33H0NC operates from 2.4-2.5 GHz and targets microwave heating applications. Under class-C operation, the WST33H0NC typically achieves 300 W of saturated output power with 14 dB of large signal gain and 75% drain efficiency via a 2.4-2.5 GHz reference design.

Available in a thermally-enhanced, Cu-based package, the WST33H0NC provides superior performance under CW operation allowing customers to improve SWaP-C benchmarks in their next-generation systems.

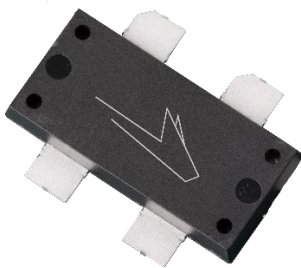


Figure 1. WST33H0NC

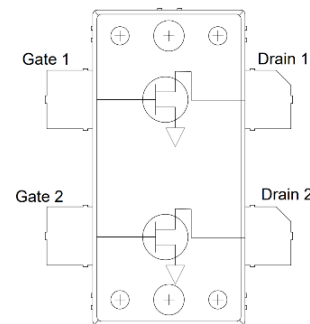


Figure 2. Functional Block Diagram

Features

- Psat: 300 W
- DE: 75 %
- LSG: 17 dB
- S21: 26 dB
- S11: -5 dB
- S22: -6 dB
- CW operation

Applications

- Microwave Heating
- Industrial, Scientific and Medical

Note: Features are typical class-C performance via a 2.4-2.5 GHz reference design under 25°C, CW operation (WST33H0NC-AMP1). Please reference performance charts for additional information.

Absolute Maximum Ratings

Parameter	Symbol	Units	Value	Conditions
Drain to Source Voltage	V_{DSS}	V	150	
Gate Voltage	V_G	V	-8,+2	
Drain Current	I_D	A	49.0	
Gate Current	I_G	mA	51.2	
Input Power	P_{in}	dBm	42 dBm	
Dissipated Power	P_{diss}	W	250	85°C
Storage Temperature	T_{stg}	°C	-65, +150	
Mounting Temperature	T_J	°C	260	30 seconds
Junction Temperature	T_J	°C	275	MTTF > 1E6
Output Mismatch Stress ¹	VSWR	Ψ	20:1	

¹ Pulsed 100 μ S, 20 %

Recommended Operating Conditions

Parameter	Symbol	Units	Typical Value	Conditions
Drain Voltage	V_d	V	50	
Gate Voltage	V_g	V	-4.0	
Drain Current	I_{dq}	mA	0	Class C, V_g -4.0
Input Power	P_{in}	dBm	39	
Case Temperature	T_{case}	°C	-40 to 85	

RF Specifications (WST33H0NC-AMP1)

Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Parameter	Units	Min	Typical	Max	Conditions
Frequency	GHz	2.4		2.5	
Output Power	dBm		55		
Drain Efficiency	%		75		
LSG	dB		17		
Small-Signal Gain (S21)	dB		26		$P_{in} = -20$ dBm
Input Return Loss (S11)	dB		-5		$P_{in} = -20$ dBm
Output Return Loss (S22)	dB		-6		$P_{in} = -20$ dBm

Notes:

- Final testing and screening for all transistor sales is performed using the WST33H0NC-AMP1 at 2.4-2.5 GHz.
- Test and screening under class-C operation for peak efficiency. User may operate under different operating class depending on specific system requirements.

Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Figure 3: Pout v. Frequency v. Temperature

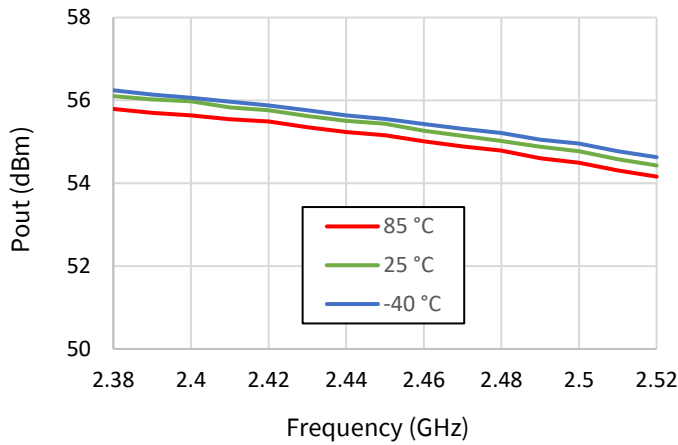


Figure 4: DE v. Frequency v. Temperature

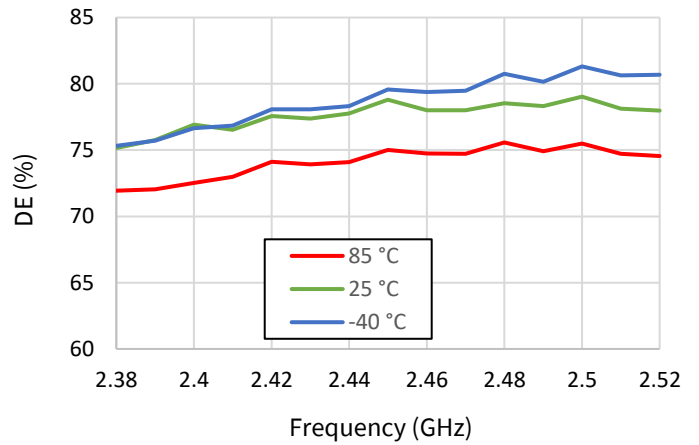


Figure 5: Id v. Frequency v. Temperature

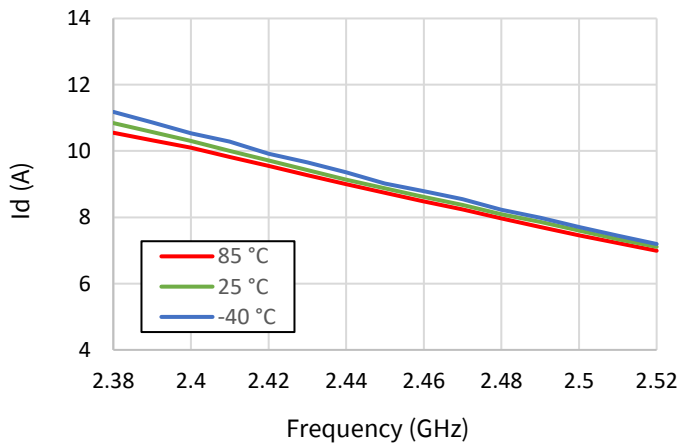


Figure 6: Ig v. Frequency v. Temperature

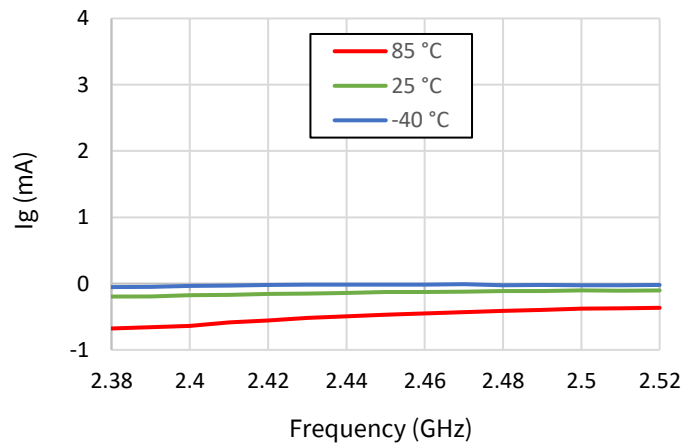
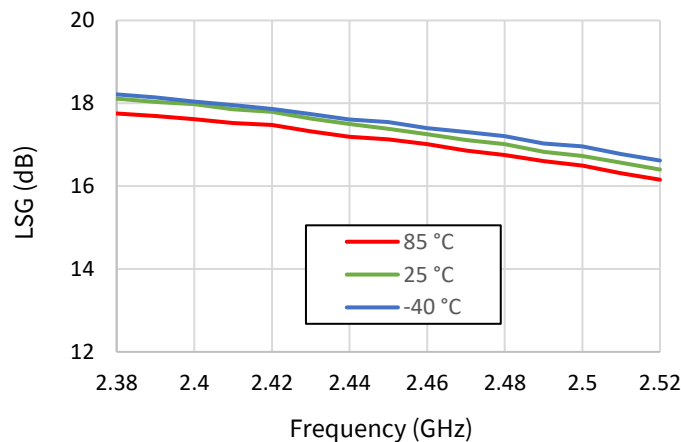


Figure 7: LSG v. Frequency v. Temperature



Test conditions unless otherwise noted: Vd=50V, CW, Pin = 39dBm, Vg=-4V, T_{base}=25°C

Figure 8: Pout v. Frequency v. Vd

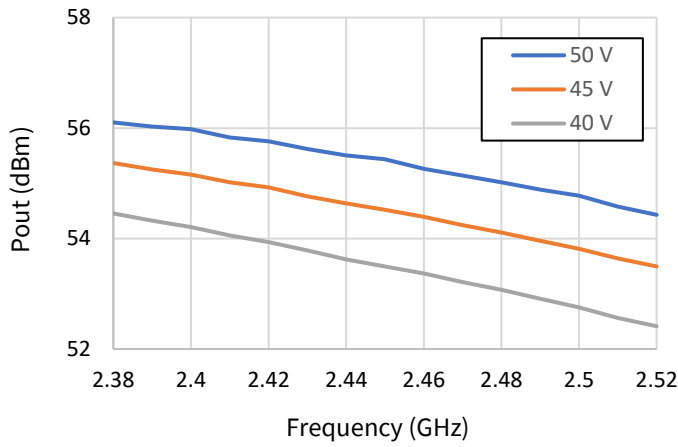


Figure 9: DE v. Frequency v. Vd

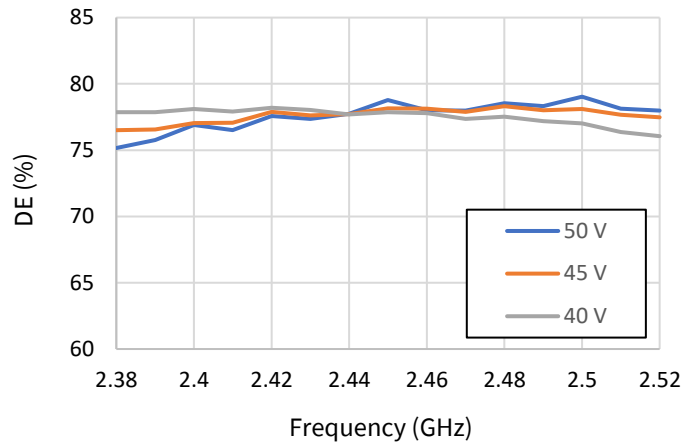


Figure 10: Id v. Frequency v. Vd

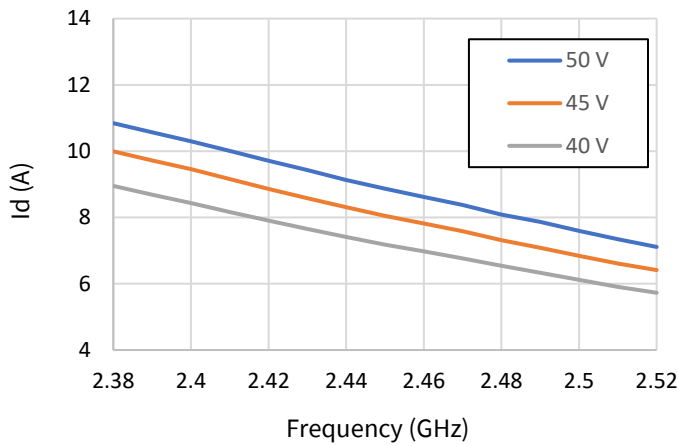


Figure 11: Ig v. Frequency v. Vd

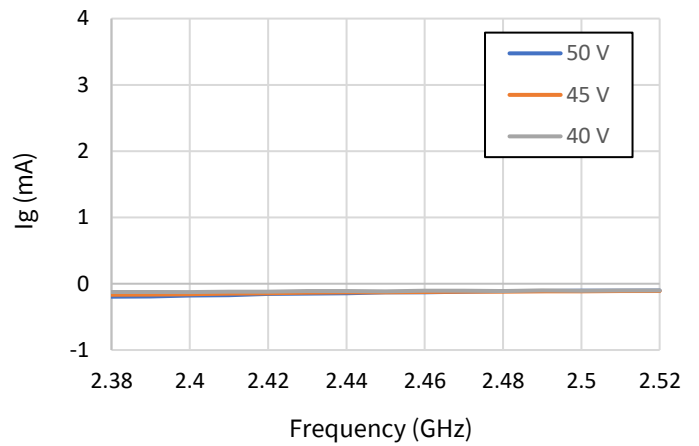
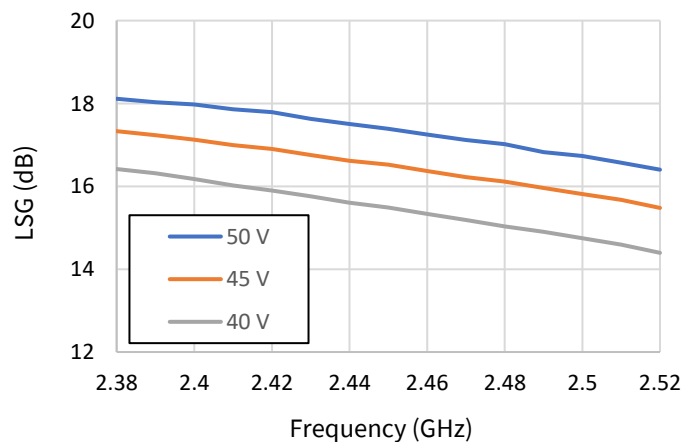


Figure 12: LSG v. Frequency v. Vd



Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Figure 13: Pout v. Frequency v. Idq

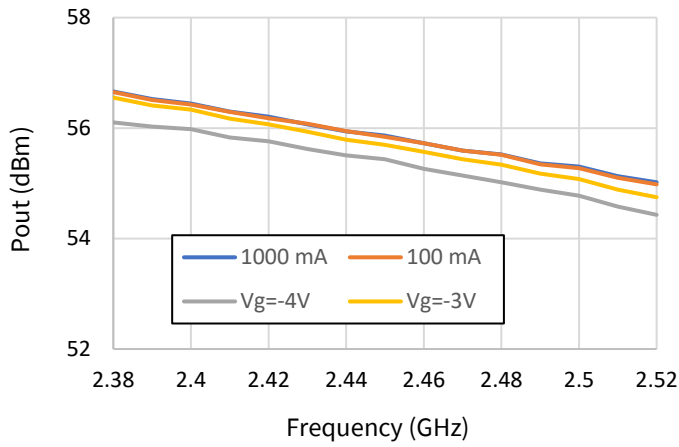


Figure 14: DE v. Frequency v. Idq

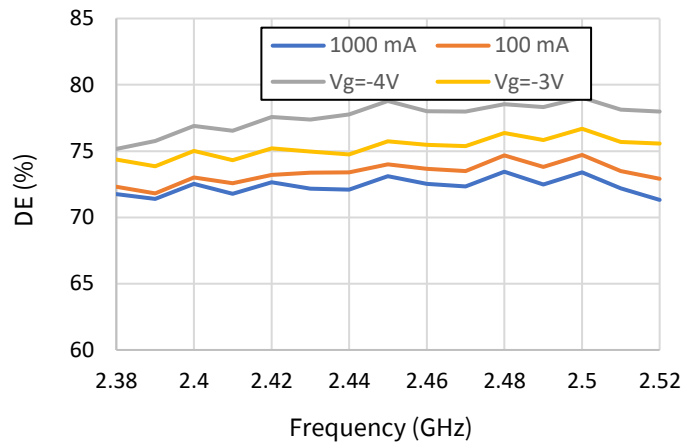


Figure 15: Id v. Frequency v. Idq

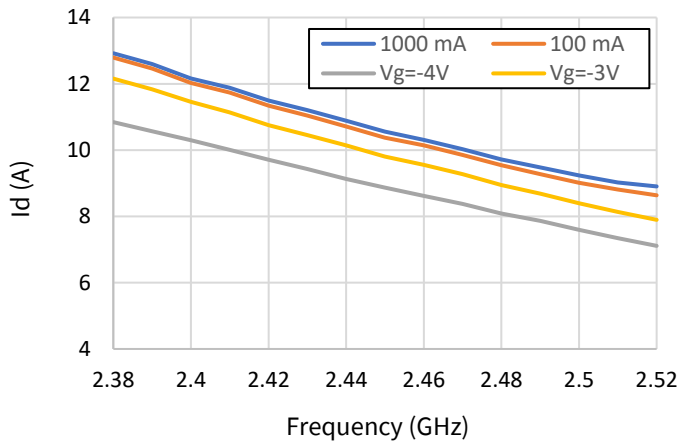


Figure 16: Ig v. Frequency v. Idq

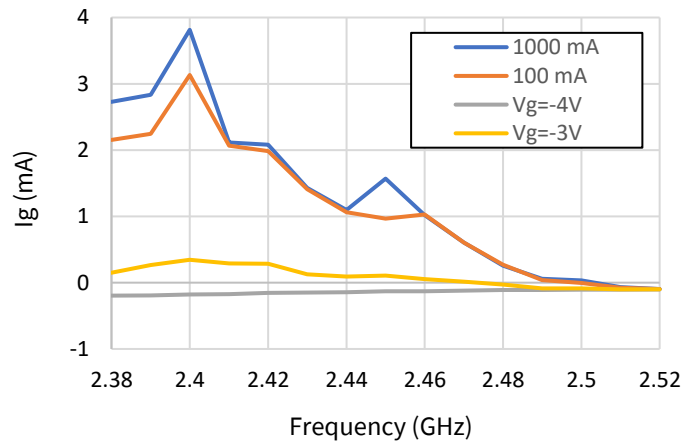
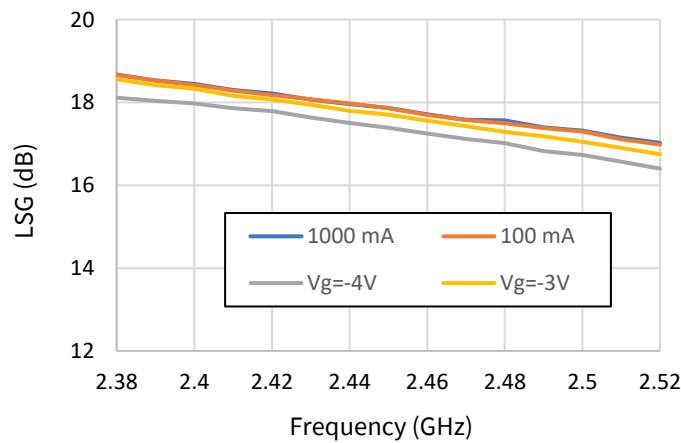


Figure 17: LSG v. Frequency v. Idq



Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Figure 18: Pout v. Pin v. Frequency

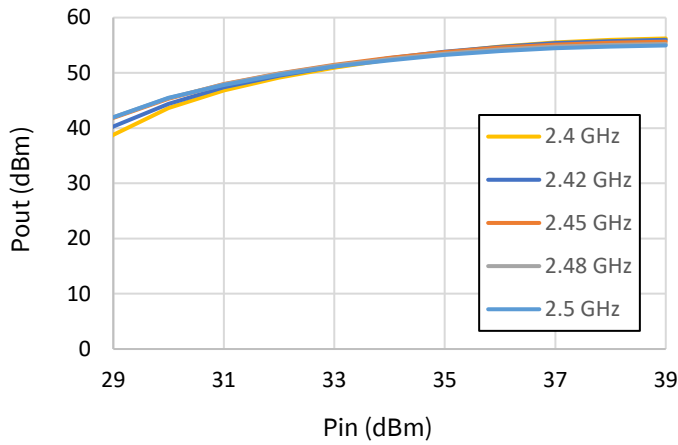


Figure 19: DE v. Pin v. Frequency

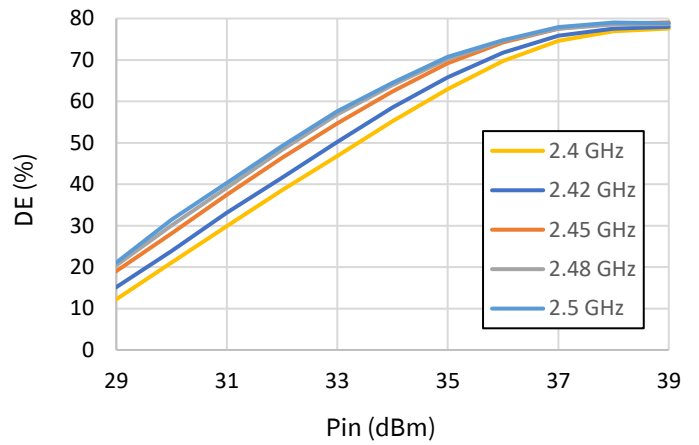


Figure 20: Id v. Pin v. Frequency

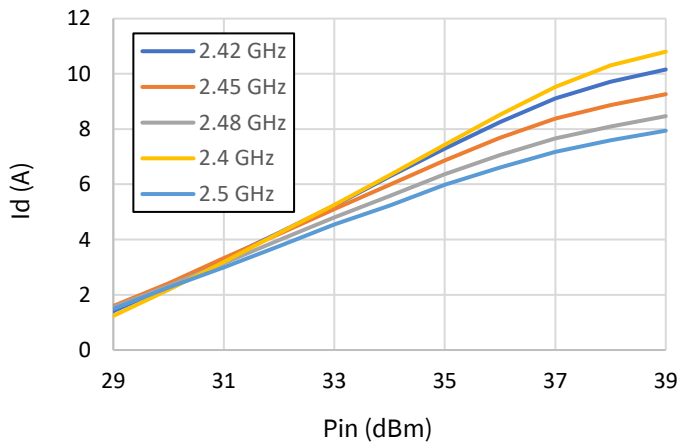


Figure 21: Ig v. Pin v. Frequency

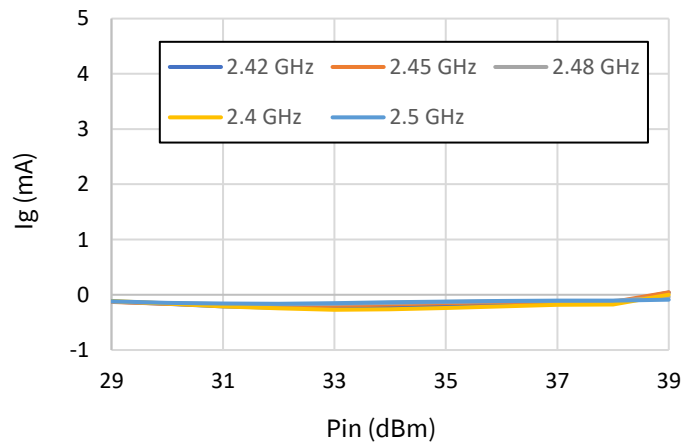
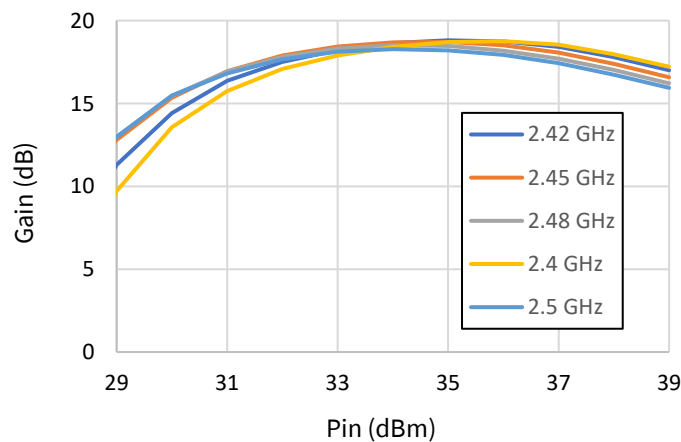


Figure 22: Gain v. Pin v. Frequency



Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Figure 23: Pout v. Pin v. Temperature

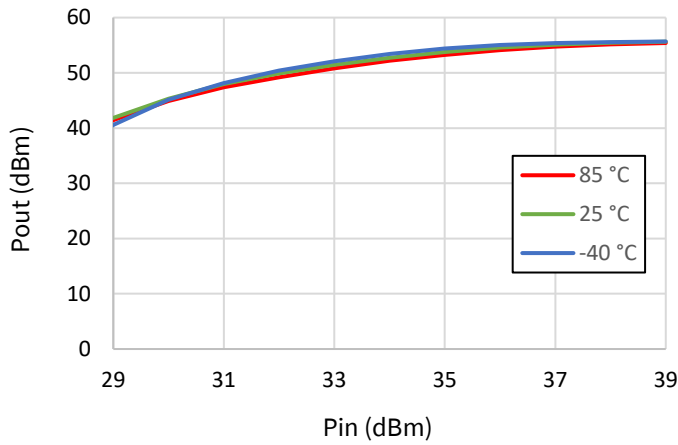


Figure 24: DE v. Pin v. Temperature

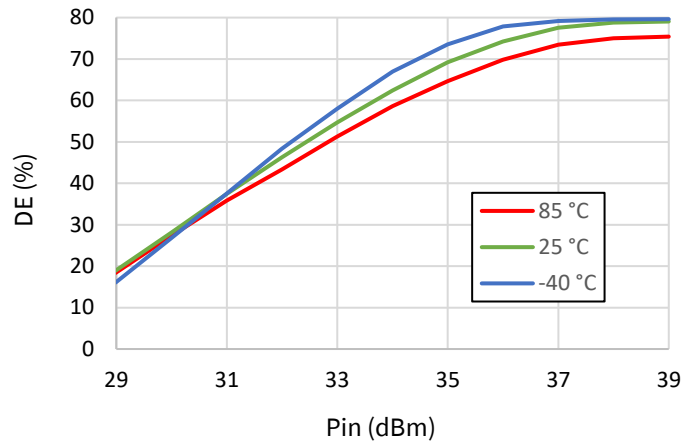


Figure 25: Id v. Pin v. Temperature

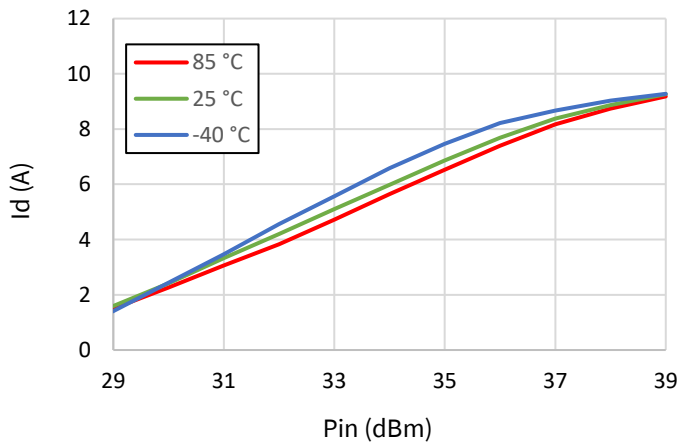


Figure 26: Ig v. Pin v. Temperature

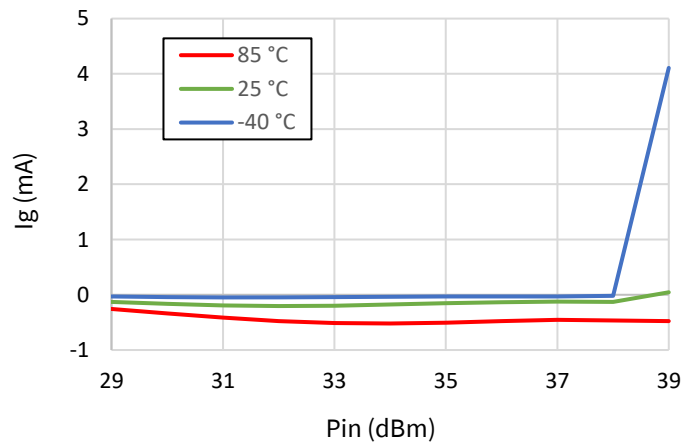
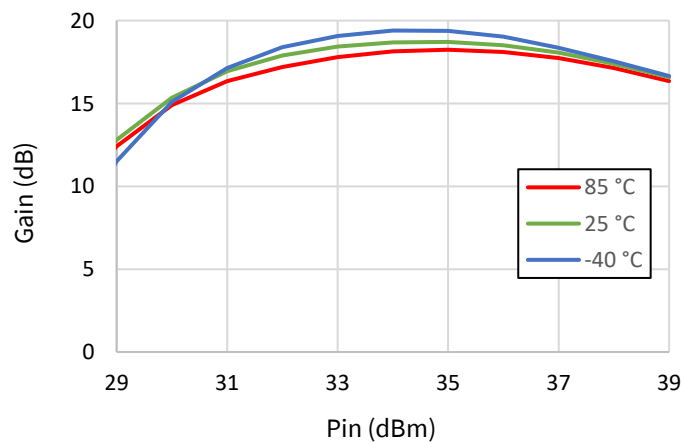


Figure 27: Gain v. Pin v. Temperature



Test conditions unless otherwise noted: Vd=50V, CW, Pin = 39dBm, Vg=-4V, T_{base}=25°C

Figure 28: Pout v. Pin v. Vd

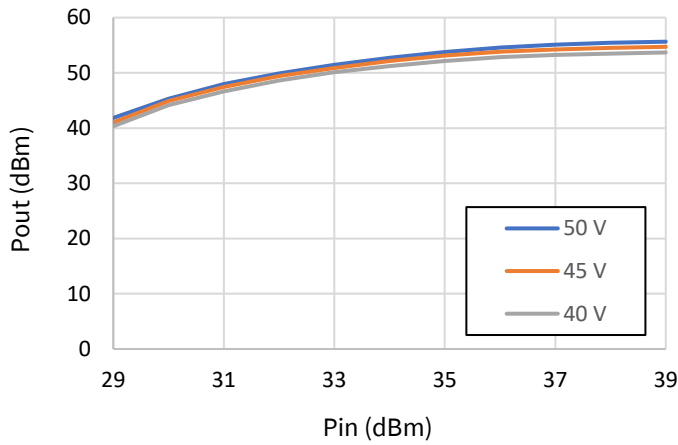


Figure 29: DE v. Pin v. Vd

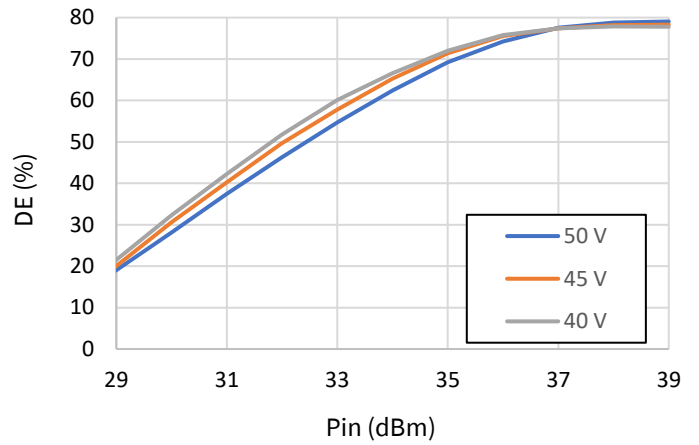


Figure 30: Id v. Pin v. Vd

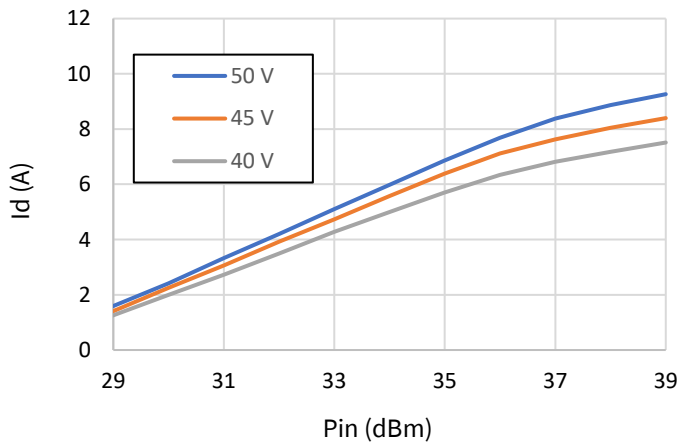


Figure 31: Ig v. Pin v. Vd

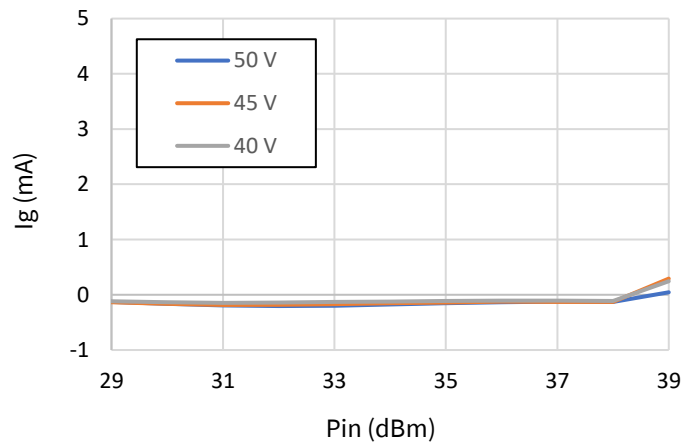
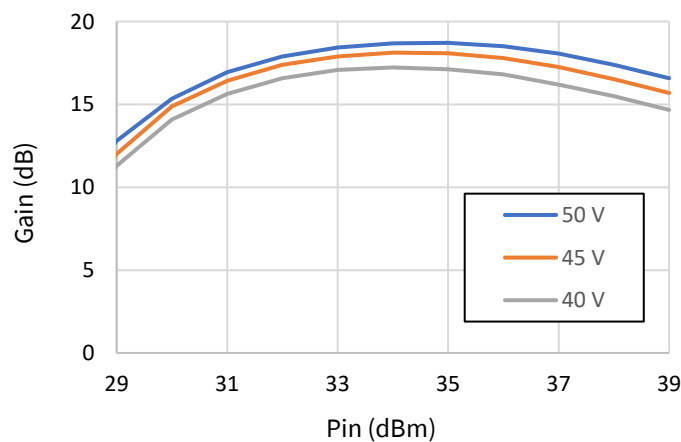


Figure 32: Gain v. Pin v. Vd



Test conditions unless otherwise noted: $V_d=50V$, CW, $P_{in} = 39dBm$, $V_g=-4V$, $T_{base}=25^\circ C$

Figure 33: Pout v. Pin v. Idq

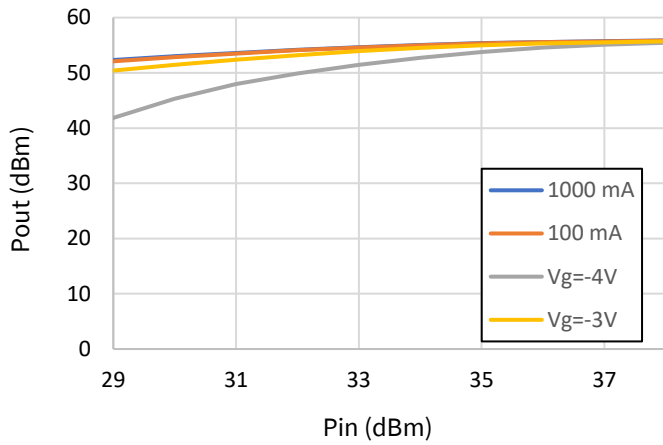


Figure 34: DE v. Pin v. Idq

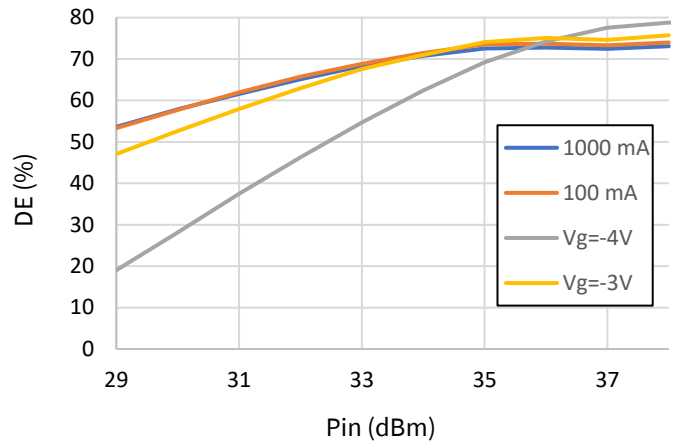


Figure 35: Id v. Pin v. Idq

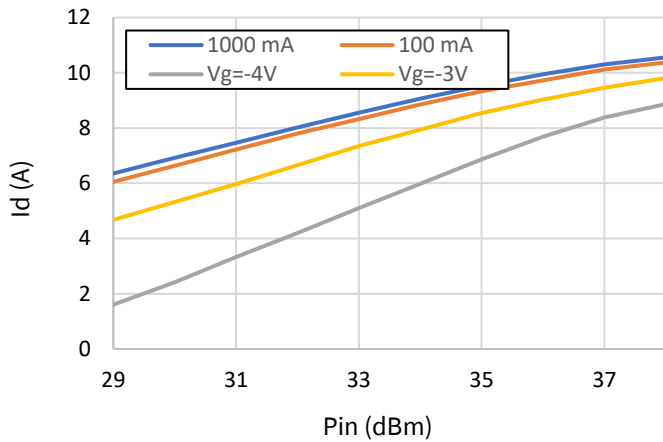


Figure 36: Ig v. Pin v. Idq

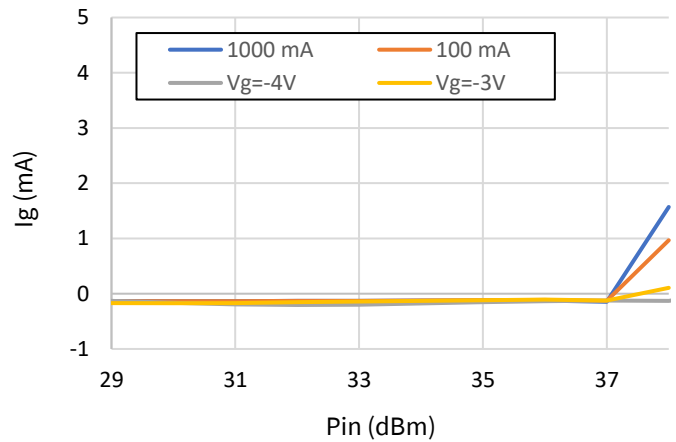
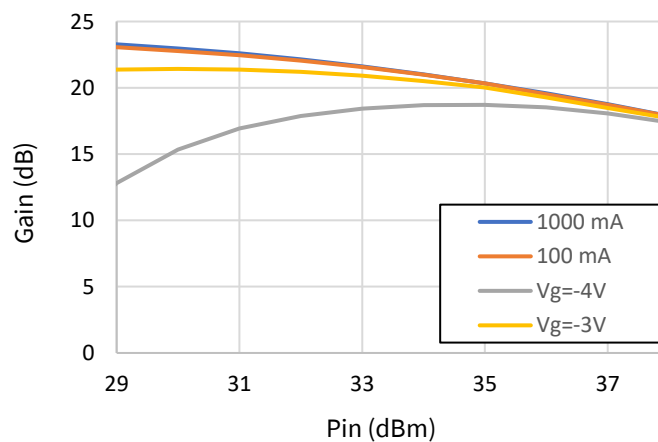


Figure 37: Gain v. Pin v. Idq



Test conditions unless otherwise noted: Vd=50V, CW, Pin = -20dBm, Idq=1000mA, T_{base}=25°C

Figure 38: S21 v. Frequency v. Temperature

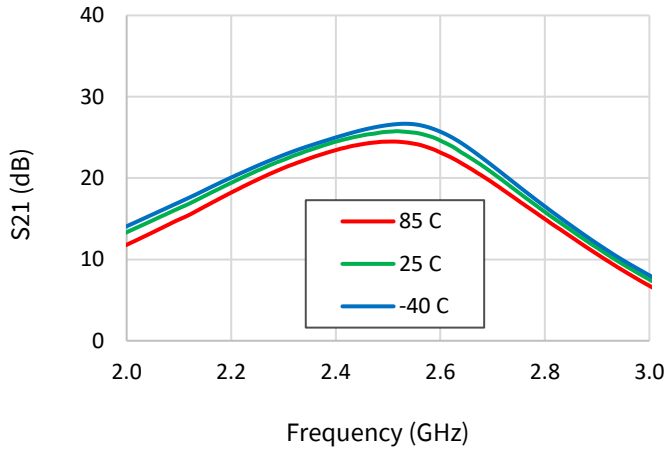


Figure 39: S21 v. Frequency v. Vd

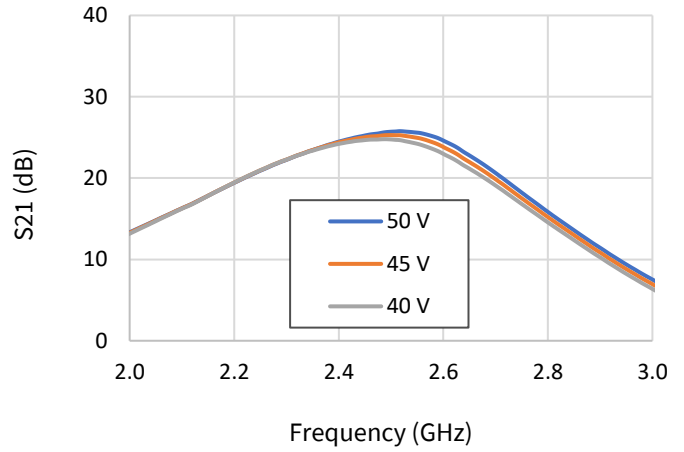


Figure 40: S11 v. Frequency v. Temperature

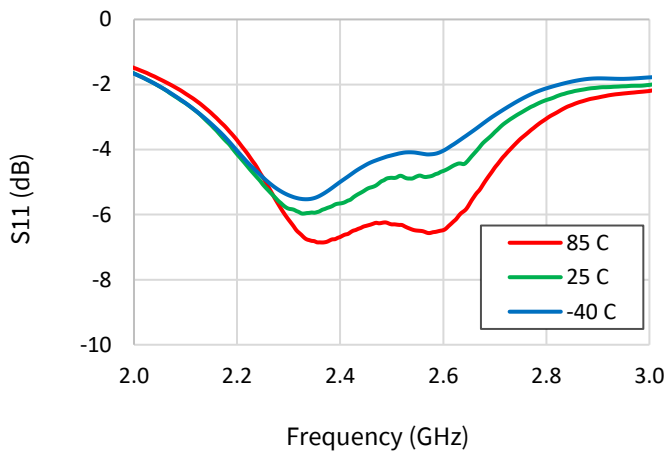


Figure 41: S11 v. Frequency v. Vd

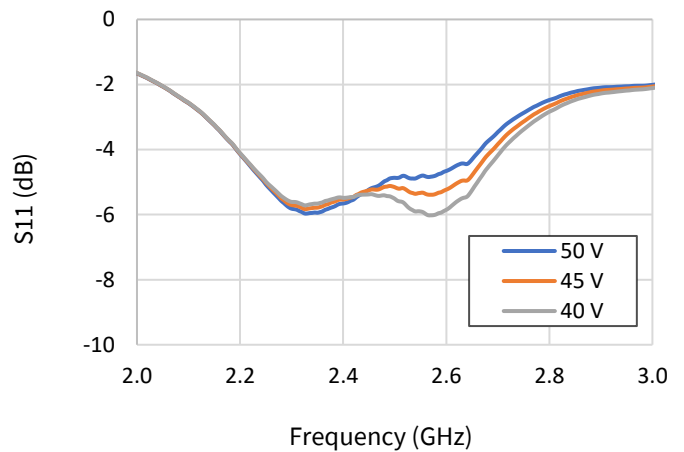


Figure 42: S22 v. Frequency v. Temperature

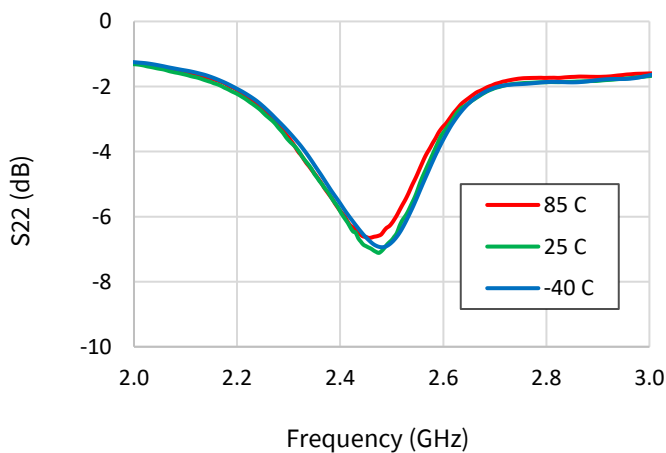
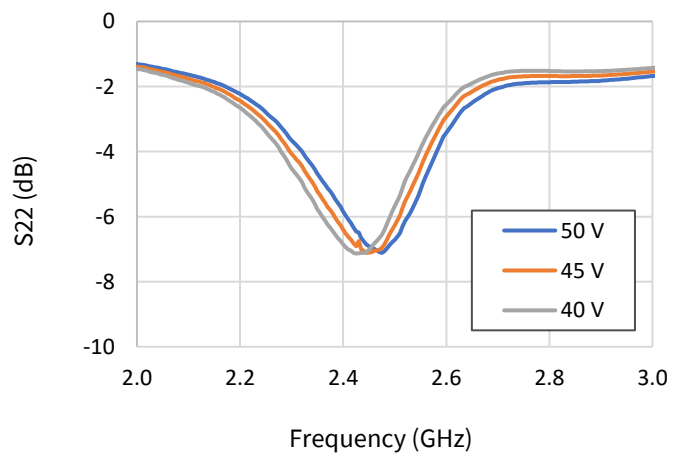


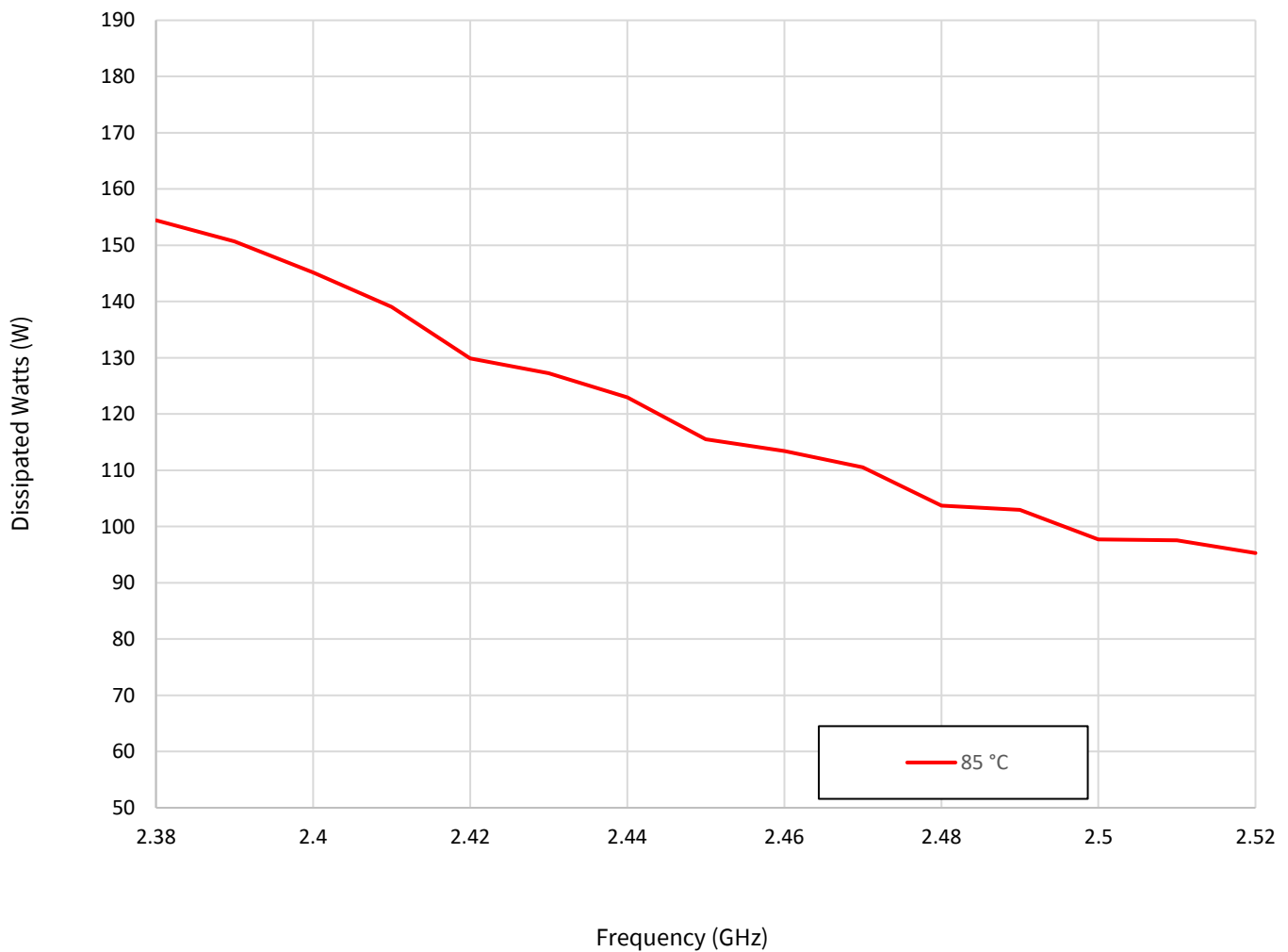
Figure 43: S22 v. Frequency v. Vd



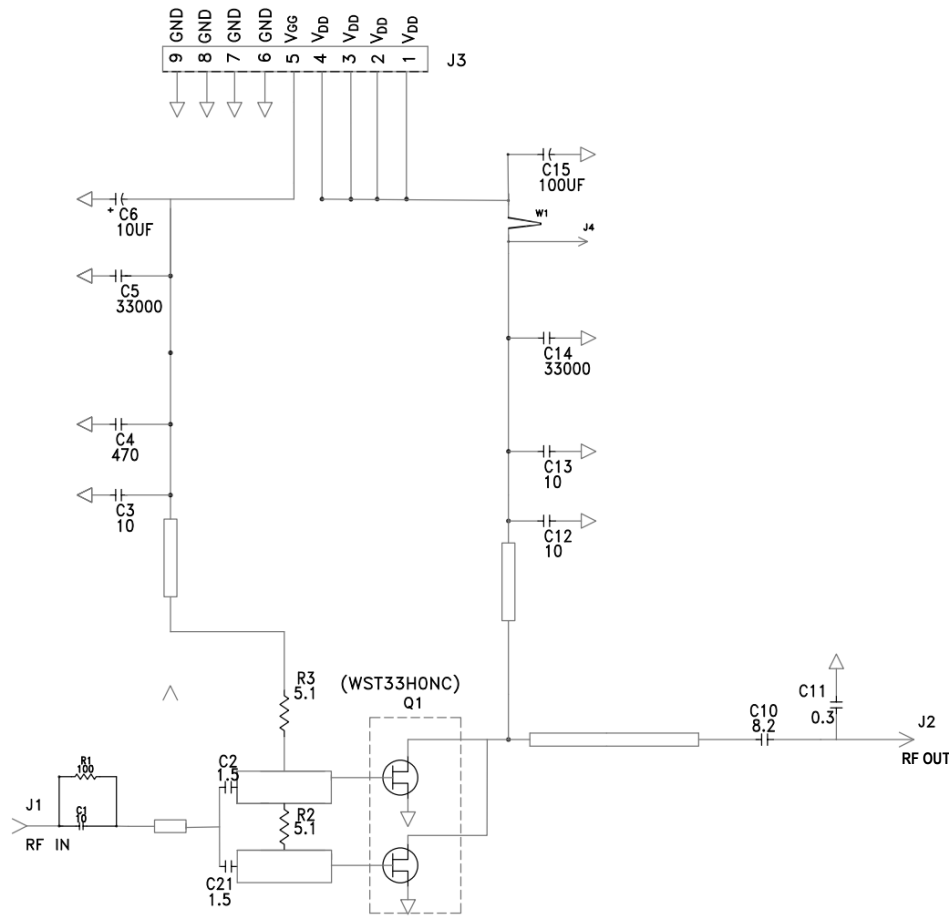
Thermal Characteristics

Parameter	Symbol	Value	Operating Conditions
Operating Junction Temperature	T_J	179°C	$V_d = 50\text{ V}$, $I_{drive} = 10.6\text{ A}$, $P_{in} = 39\text{ dBm}$, $P_{out} = 56.1\text{ dBm}$, $P_{diss} = 145\text{ W}$, $T_{case} = 85^\circ\text{C}$, CW, $V_g = -4\text{ V}$
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.65°C/W	

Power Dissipation v. Frequency ($T_{case} = 85^\circ\text{C}$)



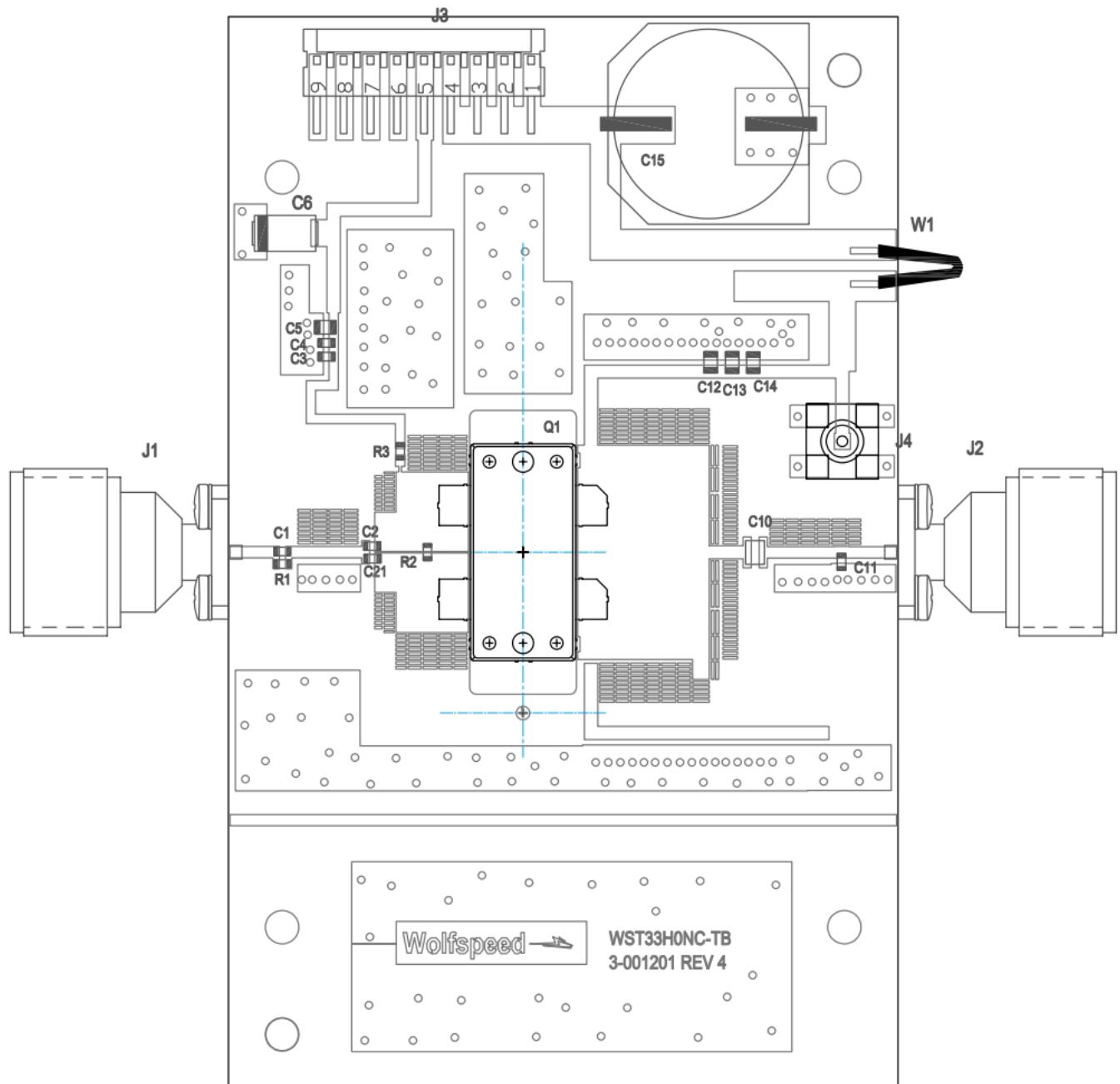
WST33H0NC-AMP1 Evaluation Board Schematic Drawing



WST33H0NC-AMP1 Evaluation Board Bill of Materials

Reference Designator	Description	Qty
C5,C14	CAP, 33000PF, 0805,100V, X7R	2
R1	RES,1/16W,0603,1%,100 OHMS	1
C12,C13	CAP, 10pF, +/- 1%, 250V, 0805, ATC600F	2
C15	CAP, 100 UF, 20%, 160V, ELEC	1
W1	WIRE, 18 AWG ~ 1.75"	1
J1,J2	CONN,N,FEM,W/.500 SMA FLNG	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
J4	CONN, SMB, STRAIGHT JACK RECEPTACLE	1
C2,C21	CAP, 1.5pF, +/-0.1pF, 0603, ATC600S	2
R3,R2	RES,1/16W,0603,1%,5.1 OHMS	2
C1,C3	CAP, 10.0pF, +/-5%, 0603, ATC600S	2
C4	CAP, 470PF, 5%,100V, 0603	1
C6	CAP 10UF 16V TANTALUM, 2312	1
C10	CAP, 8.2pF, +/-5%,500V, 0709, ATC 800R	1
C11	CAP, 0.3pF, +/-0.05pF, 0603, ATC600S	1
Q1	WST33H0NC, GaN Transistor	1
	PCB, WST33H0NC, RO6035HTC, 20 mil	1
	BASEPLATE, CU, 2.5 X 4.0 X 0.5 IN	1

WST33H0NC-AMP1 Evaluation Board Assembly Drawing



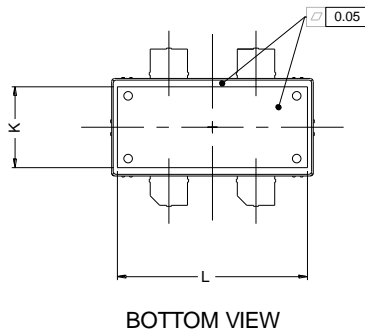
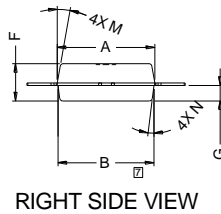
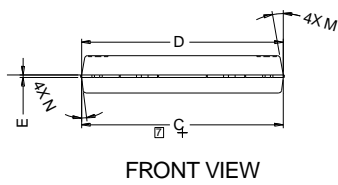
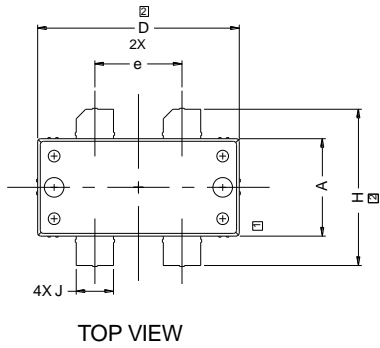
Bias On Sequence

1. Ensure RF is turned-off
2. Apply pinch-off voltage of -5 V to the gate (V_g)
3. Apply nominal drain voltage (V_d)
4. Adjust V_g to obtain desired quiescent drain current (I_{dq})
5. Apply RF

Bias Off Sequence

1. Turn RF off
2. Apply pinch-off to the gate ($V_g = -5V$)
3. Turn off drain voltage (V_d)
4. Turn off gate voltage (V_g)

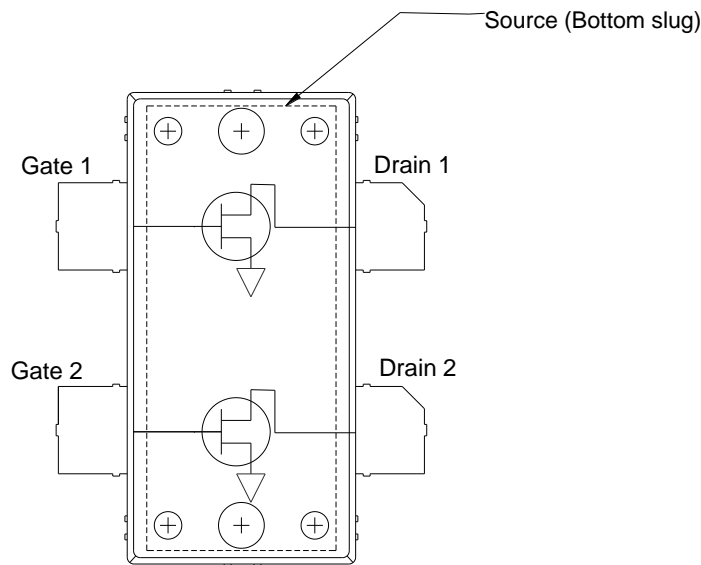
Product Dimensions



Remarks:

- Interpret dimensions and tolerances per ASME Y14.5M-1994
- Mold/Dam Bar/Metal protrusion of 0.30mm max per side not included.
- Metal protrusions are connected to source and shall not exceed 0.10mm max.
- Fillets and radii:- Unless otherwise noted all radii are 0.30mm max.
- Molded package Ra 1.2-1.6um.
- All metal surfaces are tin plated, except area of cut.
- Does not include Mold/Dam Bar and Metal protrusion.

DIM	INCHES			MILLIMETERS		
	MIN	TYP	MAX	MIN	TYP	MAX
A	0.390	0.392	0.394	9.91	9.96	10.01
B	0.383	0.385	0.387	9.73	9.78	9.83
C	0.808	0.810	0.812	20.52	20.57	20.62
D	0.808	0.810	0.812	20.52	20.57	20.62
E	0.007	0.010	0.013	0.17	0.25	0.33
F	0.148	0.150	0.152	3.76	3.81	3.86
G	0.060	0.062	0.064	1.52	1.57	1.62
H	0.624	0.628	0.632	15.86	15.96	16.06
J	0.148	0.150	0.152	3.76	3.81	3.86
K	-	0.325	-	-	8.25	-
L	-	0.764	-	-	19.40	-
M	-	10°±1°	-	-	10°±1°	-
N	-	7°±1°	-	-	7°±1°	-
e	-	0.350	-	-	8.89	-




Electrostatic Discharge (ESD) Classification

Parameter	Symbol	Class	Classification Level	Test Methodology
Human Body Model	HBM	TBD	ANSI/ESDA/JEDEC JS-001 Table 3	JEDEC JESD22 A114-D
Charge Device Model	CDM	TBD	ANSI/ESDA/JEDEC JS-002 Table 3	JEDEC JESD22 C101-C

Moisture Sensitivity Level (MSL)

Rating	Time	Conditions
MSL 3	168 hours	30°C / 60% RH

Product Ordering Information

Part Number	Description	MOQ Increment	Image
WST33H0NC	2.4 – 2.5 GHz, 300W GaN Transistor	250 (T&R)	
WST33H0NC-AMP1	2.4 – 2.5 GHz Evaluation Board	1 Each	

For more information, please contact:

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